Spallation Neutron Source

Systems Requirements
Document
for Equipment, Device and
Signal Naming

January 2000

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SPALLATION NEUTRON SOURCE SYSTEMS REQUIREMENTS DOCUMENT FOR EQUIPMENT, DEVICE AND SIGNAL NAMING

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LOCKHEED MARTIN ENERGY RESEARCH CORPORATION

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January 2000

R. E. Etheridge Conventional Facilities Division Director	
R. Kustom Accelerator Division Director	Date
T. E. Mason Experimental Facilities Division Director	Date
L. E. Temple SNS Project Director	Date

CONTENTS

	Page
LIST OF FIGURES	v
LIST OF TABLES	vii
1. PURPOSE	1
2. SCOPE	1
3. Requirements.	. 1

LIST OF TABLES

Table		Page
1.	Numbering requirements.	. 2
2.	Syntax rules	. 3
3.	Systems codes	. 4
4.	Subsystem codes	. 5
5.	Device codes	. 7
6.	Signal codes	. 9
7.	Instance Numbering	10

1. PURPOSE

This requirements document documents the equipment, device, and signal naming and numbering to be used for all SNS systems.

2. SCOPE

These requirements applies to all devices (beam instrumentation, sensors, control elements, etc.), equipment (power supplies, magnets, Rf cavities, targets, moderators, instruments, etc.) and signals in technical systems and conventional facilities. These requirements do not apply to cable numbering, pipe numbering, or location designations throughout the facility.

3. Requirements

Format and syntax shall be as shown on Figure 1.

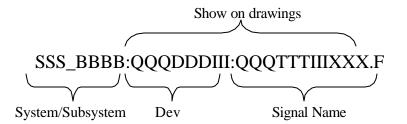


Figure 1: Format and Syntax

Requirements and control of specific naming elements are listed in Table 1 below.

Table 1. Numbering requirements

Naming part	Description	Requirements	Controlled by	Remarks
Format and Syntax	Entire name	Figure 1 and Syntax rules in Table 2	Project Director	
Drawing Numbers	Numbering on drawings	Figure 1. System and subsystem must be shown for equipment in systems not in the system shown on the drawing	Division Director	
SSSS	System	Names on Table 3	Division Director	
		Subsystem name on Table 4 may be used if it clearly indicates its system		
BBBB	Subsystem	Names on Table 4.	Senior Team Leaders	
		May be omitted if subsystem is obvious from system name or device name.		
QQQQ	Device Qualifier	Use is optional. Qualifiers are assigned by WBS Level 3 task leaders (Could be an associated piece of equipment)	Level 3 Task Leaders	Example: <u>SpI</u> Tnk for spill tank or HX1_TE101 for temperature element on a heat exchanger.
DDDD	Device Type	Names on Table 5 or IEEE 803 Recommended Practice for Unique Identification in Power Plants and Related Facilities for conventional facilities or assigned by STL.	Table 4 by Senior Team Leader for Global Controls	
Ш	Device Instance	Number per Table 7. Numbers are assigned by Level 3 task leaders	Senior Team Leaders	Example: Tnk101 or SplTnk101 for spill tank
QQQQ	Signal Qualifier	Use is optional. Qualifiers assigned by WBS Level 3 task leaders	Level 3 Task Leaders	
TTTT	Signal Type	Table 6 or assigned by Level 3 Task Leader	Level 3 Task Leaders	
XXXX	Suffix	Use is optional. Qualifiers assigned by WBS Level 3 task leaders ISA Standard S5.1 Instrumentation Symbols and Identification where applicable	Level 3 Task Leaders	
F	Field Name	Used by EPICS software programmers only	STL for Global Controls	

Table 2. Syntax rules

Name part		Syntax rules
Syntax rules for the general naming format		The delimiter "_" is used to separate system and subsystem names. The delimiter ":" is used to separate equipment or device name from its system/subsystem prefix.
	2.	Subsystem names are optional and may be omitted if subsystem is obvious from preceding system name or from succeeding equipment or device name.
	3.	The first character of each name (SystemName, SubsystemName, etc.) shall be alphabetic.
	4.	Alphabetic characters "I" and "O" should not be used where they introduce the potential of confusion with the numbers "1" and "0".
	5.	Letter case shall not be used to distinguish between names. That is, there shall never be two names for which the only difference is letter case.
	6.	Letter case shall be used to improve readability. The first letter of a word or abbreviation shall be capitalized; succeeding letters shall be lower case. Acronyms shall be all capital letters.
	7.	The only non-alphabetic characters used shall be ":" and "_". The colon (":") shall be used only as a delimiter between name parts. The underscore ("_") shall not be used as part of the system name and shall be used only as a delimiter prefix in the subsystem name. However in the equipment name "_" can be used as desired to improve readability (but not as a first character).
Syntax rules for Signal	1.	The first character shall be alphabetic.
Names (See Figure 1)	2.	Alphabetic characters "I" and "O" should not be used where they introduce the potential of confusion with the numbers "1" and "0".
	3.	Letter case shall not be used to distinguish between names. That is, there shall never be two names for which the only difference is letter case.
	4.	Letter case shall be used to improve readability. The first letter of a word or abbreviation shall be capitalized; succeeding letters shall be lower case. Acronyms shall be all capital letters.
	5.	The only non-alphabetic characters used shall be "_", which can be used as desired to improve readability (but not as a first character).

Table 3. System codes

WBS	System code	System code description	
1.3	FE	Front End Systems	
1.3	LBT	LEBT	
1.3	MBT	MEBT	
1.3	RFQ	RF quadrupole	
1.3	Src	Ion source	
1.4	Lin	Linac	
1.4	DTL	Drift tube linac	
1.4	CCL	Coupled cavity linac	
1.4	SCL	Superconducting linac	
1.4	CHL	Central Helium Liquefier	
1.5	HBT	HEBT	
1.5	Rng	Ring	
1.5	RTBT	RTBT	
1.6	Tgt	Target systems	
1.6	EDmp	Ring extraction dump	
1.6	IDmp	Ring injection dump	
1.6	LDmp	Linac dump	
1.7	ISF	Instrument Support Facilities	
1.7	Instr	Instruments	
1.8	CF	Conventional Facilities	
1.8	ELC	Power and communication systems	
1.8	MECH	HVAC and utilities systems	
1.8	WSTE	Waste systems	
1.9	ICS	Integrated Control System	
1.9	PPS	Personnel Protection System	

Table 4. Subsystem codes

Subsystem Codes Subsystem		
code	Subsystem description	
Accl	Accelerator	
Cryo	Crogenics	
Ctl	Control system	
CWS	Chilled Water System	
Diag	Diagnostics	
DIWS	Deionized Water System	
Extr	Extraction	
Gen	General	
Inj	Injection	
Mag	Magnets	
PS	Power Supply	
RF	RF systems	
Tim	Timing	
Vac	Vacuum	
Bnch	(MEBT) buncher	
S3B	(MEBT) section 3, Part B	
Mod1AL	(RFQ) module 1, Part A, Left	
Mod4DB	(RFQ) module 4, Part D, Bottom	
Mod	Target module	
Proc	Target process systems	
Hg	Target mercury loop	
Tran	Target transport systems	
Amb1	Ambient-temp. moderator #1 (for system TMod)	
Amb2	Ambient-temp. moderator #2 (for system TMod)	
Cry 1	Cryogenic moderator #1 (for system TMod)	
Cry2	Cryogenic moderator #2 (for system TMod)	
In	Reflector inner plug (for system TRef)	
Mid	Reflector middle plug (for system TRef)	
Out	Reflector outer plug (for system TRef)	
Core	Core vessel (for system TVes)	
Win	Proton beam window (for system TVes)	
Upr	Upper vessel (for system TVes)	
Bulk	Bulk shielding components (for system TSh)	
Shel	External shell (for system TSh)	
Shtr	Shutter systems (for system TSh)	
BL1	Neutron beam line #1 (for system TSh)	
Roof	Target roof structure (for system TSh)	
DIWS	Deionized cooling water subsys. (for system TUtl)	
PWCS	Proton window cooling water subsys. (for sys TUtl)	
D2O	Heavy water cooling subsys. (for system TUtl)	
CCS	Cryo moderator shid. cooling subsys (for sys TUtl)	
TCS	Target ass'y/shroud cooling subsys (for sys TUtl)	
MCS	Ambient moderator cooling subsystem (for sys TUtl)	
Vac	Vessel vacuum subsystem (for sys TUtl)	
He	Helium gas subsystem (for sys TUtl)	
Cell	Maintenance shell subsystems (for sys TRH)	
Bay	High-bay maintenance subsystems (for sys TRH)	
BL	Beamline maintenance subsystem (for sys TRH)	
Vlt	Utility vault maintenance subsystem (for sys TRH)	
LDmp	Linac beam dump maint subsys (for sys TRH)	
IDmp	Ring injection dump maint subsys (for sys TRH)	
EDmp	Ring extract dump maint subsys (for sys TRH)	
iip	Tang ora act dump mame bacogo (101 by b 1101)	

Subsystem	
code	Subsystem description
CR	Remote handling control room (for sys TRH)
TMod	Target moderator systems
TRef	Target reflector assemblies
TRH	Target remote handling
TSh	Target station shielding
ΓUtl	Target utility systems
ΓVes	Vessel assemblies
BmLn	Incident instrument beam line
Chop	Neutron beam chopper
FltPth	Flight path
Guide	Instrument neutron guide tubes
Samp	Sample chamber
DAS	Data Acquisition System
Inel1	Spectrometer, microvolt
nel2	Spectrometer, 100 microvolt
Inel4	Spectrometer, wide angle chopper
nel5	Spectrometer, large solid angle single crystal
Pow3	Powder diffractometer, long wavelength
Pow6	Powder diffractometer (strain; high resolution)
Pow7	Powder diffractometer (for glasses and liquids)
Ref1	Reflectometer, vertical refl. plane
SANS2	Small angle neut scattering, Gen/lower Q high res
CD1	Diffractometer, general purpose single crystal
301	Bldg no. 8001 (typical format for any bldg no.)
inTnl	Linac tunnel
RngTnl	Ring tunnel
[nl	Pertaining to tunnels
[gt	Pertaining to target building
Site	Site (e.g. PPS site rad monitors)
SubSt	Electrical substation
CCR	Central Control Room
BHWS	Building Heating Water System
CA	Compressed air system
CWS	Chilled Water System
DCW	Deionized Cooling Water System
DWS	Demineralized Water System
Elec	Electrical power and communication systems
FCryo	Facility cryogenic systems
FGas	Facility gas distribution systems
FVac	Facility vacuum system
GWTS	Gaseous waste treatment systems
HVAC	Heating, ventilation, and air conditioning systems
LLLW	Liquid low-level waste treatment systems
NG	Natural gas systems
PWS	Process Water System
PWS PWTS	Process Water System Process waste treatment sytems

Table 5. Device type

- I	Table 5. Device type	
Device code	Device code description	
AHU	Air handling unit	
ANPS	Anode power supply	
BCM	Beam current monitor	
BIG	Beam in gap monitor	
Bldg	Building	
BLM	Beam loss monitor	
BPM	Beam position monitor	
BPMH	Beam position monitor, horizontal	
BPMV	Beam position monitor, vertical	
Cab	Instrument and control cabinets	
Cbl	Cable	
Cav	RF cavity	
CCG	Cold cathode vacuum gage	
Colim	Collimator	
Damp	Damper	
DCBPM	DC beam position monitor	
DCH	Dipole magnet, corrector, horizontal	
DCV	Dipole magnet, corrector, vertical	
DEC	Decapole magnet	
DH	Dipole magnet, horizontal	
Dr	Door	
DV	Dipole magnet, vertical	
EKick	Extraction kicker	
Fan	Fan	
FBCM	Fast Beam Current Monitor	
FBLM	Fast Beam Loss Monitor	
Flt	Filter	
FV	Fast valve	
GBPS	Grid bias power supply	
HX	Heat exchanger	
IG	Ion gage	
IKick	Injection kicker	
IP	Ion pump	
IX	Ion exchanger	
Mix	Agitators, mixers	
Mo	Motor	
Mod	Modulator	
MV	Manual valve	
NEGP	Non-evaporable getter pump	
OCT	Octupole magnet	
OctH	Octupole magnet, horizontal	
OctV	Octupole magnet, vertical	
PA	Power amplifier	
PADPS	Power amplifier driver power supply	
Pen	Penetration	
Pipe	Pipe	
Pmp	Pump	
PrM	Beam profile monitor	
PrMH	Beam profile monitor, horizontal	
PrMV	Beam profile monitor, vertical	
Q	Quadrupole magnet	
QH	Quadrupole magnet, horizontal	
QS	Quadrupole magnet, skew	

Table 5. Device type (continued)

Device code	Device type description
QSH	Quadrupole magnet, skew, horizontal
QSV	Quadrupole magnet, skew, vertical
QV	Quadrupole magnet, vertical
Rg	Regulator
RGA	Residual gas analyzer
RP	Roughing pump
RV	Roughing valve
Scrp	Scraper
SGV	Sector gate valve
Sh	Shield
SPS	Screen power supply
SX	Sextupole magnet
SXH	Sextupole magnet, horizontal
SXS	Sextapole magnet, skew
SXSCH	Sextupole magnet, skew, corrector, horizontal
SXSCV	Sextupole magnet, skew, corrector, vertical
SXSH	Sextupole magnet, skew, horizontal
SXSV	Sextupole magnet, skew, vertical
SXV	Sextupole magnet, vertical
TCG	Thermocouple vacuum gage
Tk	Tanks, receivers
TMP	Turbomolecular pump
TNR	RF tuner
TPS	Tuning power supply
TSP	Titanium sublimation pump
Twr	Tower
Vlt	Vault
Vlv	Valve
VS	Vacuum sector
Vsl	Vessel
WCM	Wall current monitor
WvG	Waveguide

Table 6. Signal type

Signal code	Signal code description	
В	Field	
Clk	Clock	
Cmd	Command (e.g. start/stop)	
Ctl	Control (e.g. on/off)	
Dr	Door (e.g. interlock)	
DP	Differential pressure	
Flw	Flow (just analog or either analog/digital?)	
Fn	Function	
G	Gain	
Hor	Horizontal (e.g. BPM horizontal position)	
Ver	Vertical (e.g. BPM vertical position)	
Hall	Hall probe	
I	Current	
Cur	Beam current	
Lim	Limit	
Lk	Leak	
Lv	Level	
OI	Over-current	
OT	Over-temperature	
OV	Over-voltage	
P	Pressure	
pН	pH	
Pos	Position	
UPos	Upstream position (e.g. collimator upstream pos)	
Pw	Power	
Rd	Radiation	
Spd	Speed	
Sts	Status	
Tm	Time	
T	Temperature	
V	Voltage	
DPos	Downstream position (e.g. collimator downstrm pos)	
Pr	Profile (vector or array) (e.g. horiz profile mon)	

Table 7: Instance Numbering

C1		Instance Numbering
Subproject	Instance Numbering	
Front End	Some devices span all the Front End subsystems and therefore will appear a generic "Front End" devices.	
	English from English	
	Examples from Front End:	Front and Ion Course 1
	FE_Vac:IG01 FE_Vac:VLV02	Front end; Ion Gauge 1 Front end; Valve 2
	FE_Vac:IP03	Front end; Ion Pump 3
	FE_Cool:H20_4	Front end; H20 loop 4
	1 L_C001.1120_4	110ht cha, 1120 100p 4
	Most devices are associate guidelines.	d with particular subsystems, and follow the general
	Examples from Source:	
	Src1:Ovn	Source 1; Oven
	Src1:RF	Source 1; RF
	Examples from LEBT:	
	LBT1:Chop1V	LEBT 1; Chopper 1, Vertical
	LBT1:L3V	LEBT 1; Lens 3, Vertical
	Examples from MEBT:	
	MBT1:QH01	MEBT1; Quad 1, Horizontal
	MBT1:Scnr02	MEBT1; Scanner 2
	MBT1:Bnch	MEBT1; Buncher
	MBT1:BPM03	MEBT1; Beam Position Monitor 3
	MBT1:FC04	MEBT1; Faraday Cup 4
	Examples from RFQ:	
	RFQ1:Kly	RFQ1; Klystron
	RFQ1_Mod1AL:Tnr	RFQ1; Module 1, Section A, Left; Tuner
Linac		er smaller components as follows: modules, segments,
		nt of modules may change in some SNS upgrade
	_	ing of segments increases continuously, independent of
	DTL, CCDTL and CCL boundaries, and independent of possible reconfigurations rf power. Also, magnetic lattice elements and beam instruments are located betw	
	segments. For these reasons, li	nac devices will be instantiated using the number of the
	preceding segment. For exar	mple:
	CCL:QH122	Horizontally focusing quadrupole after segment 122
	CCL:BPM122	Beam position monitor located after segment 122
	CCL:QH123	Horizontally focusing quadrupole located after 123
	CCL:PS_QH123	Power supply powering QH123
	CCL:QV124	Vertically focusing quadrupole after segment 124
	CCL:DCV124	Vertical Steering Magnet (Dipole Corrector -

		Vertical) after segment 124		
	CCL:Tor124	Toroid located after segment 124		
	CCL:PrMH125	Horizontal Profile Monitor after segment 125		
	CCL_Vac:IG156	Ion Gauge located after segment 156		
Ding		· · ·		
Ring	Ring magnets and power supplies instances will be assigned as follows. The ring			
	lattice consists of four superperiods, each containing a 90 degree arc and a long straight			
	section. The four superperiods are labeled A, B, D, and run sequentially along the			
	_	rection from the beginning of one arc to the beginning of the next. The order of		
	magnets in each superperiod X is DHX1, QVX1,,QHX10, QVX11, QHX12 D and Q denote dipoles and quadrupoles, and H and V refer to the horizontal and vertical planes. The long straight sections in superperiod X run from QHX8 through the control of			
	QHX12.			
	Devices in the beam transport lines will be labeled similarly except that there will be			
	no superperiod. Devices will be numbered sequentially from a starting point.			
	Examples of Ring power supply devices follow:			
	Rng1_PS:DVA3	Ring, Power Supply, Dipole Vertical, superperiod A, #3		
	Rng1_PS:QHB1	Ring, Power Supply, Quadrupole, Horiz., superperiod B, #1		
	Rng1_PS:DCHA4	Ring, Power Supply, Dipole Corrector Horiz, #4		
	Instance designations for ring equipment not directly related to a specific ring or transport line location will be simply assigned a sequential number.			
	Examples of ring vacuum devices:			
	Rng1_Vac:FV1			
	HBT_Vac:IP3 RTBT_Vac:SGV2			
	Ring1_Vac:TSP2			
	Examples of ring diagnostic devices:			
	Rng1_Diag:BCM1	Ring, Diag, BCM, #1		
	Rng1_Diag:BLM5	Ring, Diag, BLM, #5		
	Rng1_Diag:BPMH1			
	Examples of ring RF devices:			
	Ring1_RF:Cav			
	Ring1_RF:PA			
	Examples of other ring devices:			
	HBT:Colim1 HEBT, Collimator#1			
	HBT:Colim2 HEBT, Collimator#2 Downstream position			

Target Systems	The device and instance naming convention should be based on the convention in		
	IEEE 803.1. Instance numbers should be as follows:		
	WBS	NAME	NUMBERS
	WBS 1.6.1	Mercury loop	5000 – 5499
	WBS 1.6.2	• •	6000 – 6999
	WBS 1.6.3	Reflector	7000 – 7499
	WBS 1.6.4	Vessel	7500 – 7999
	WBS 1.6.5	Shielding	8000 – 8499
	WBS 1.6.6	LWS1	1000 – 1499
	WBS 1.6.6	LWS2	1500 – 1999
	WBS 1.6.6	LWS3	2000 – 2499
	WBS 1.6.6	D2O	2500 – 2999
	WBS 1.6.6	Helium	3000 – 3499
	WBS 1.6.6	Vacuum	3500 – 3999
	WBS 1.6.7	Remote H.	4000 – 4999
	WBS 1.6.8	TPS	5500 – 5999
	WBS 1.6.9	Linac dump	9000 – 9299
	WBS 1.6.9	Beam inj. Dmp	9300 – 9599
	WBS 1.6.9	Beam ext. dmp	9600 – 9999
		Miscellaneous	0000 – 0999
	WBS 1.9.6	Control	8500 – 8999
	The offgas and waste handling equipment should be included with one of these loops. Use the miscellaneous category for equipment not included with other systems.		
Based on this a pressure gauge in the utility loop LWS1 would Tgt_LWS1:Device1Instance, for example a tank in loop LWS1			
	Tgt_LWS1:Tk1001 A pressure instrument connected to the tank could be named Tgt_LWS1:PE1002		
Experiment	Systems in support facilities should use the instance numbering technique used for		
Systems	conventional facilities process instrumentation. For equipment and devices associated		
	with neutron beam lines or instruments, the first digit in the instance number should		
	indicate the bear	m line or instrun	nent number.
Conventional	Equipment and associated "Tag Names" should be named according to IEEE 803,		
Facilities	IEEE Recommended Practice for Unique Identification in Power Plants and Related		
	Facilities, which references the Instrument Society of America (ISA) Standard S5.1		
	("Instrumentation Symbols and Identification"). Instance number ranges will be assigned to appropriate subsystems as part of the review and comment effort.		Identification").